

2N7000 / 2N7002 / NDS7002A N-Channel Enhancement Mode Field Effect Transistor

Features

- High Density Cell Design for Low R_{DS(ON)}
- Voltage Controlled Small Signal Switch
- Rugged and Reliable
- High Saturation Current Capability

Description

These N-channel enhancement mode field effect transistors are produced using ON Semiconductor's proprietary, high cell density, DMOS technology. These products have been designed to minimize on-state resistance while providing rugged, reliable, and fast switching performance. They can be used in most applications requiring up to 400 mA DC and can deliver pulsed currents up to 2 A. These products are particularly suited for low-voltage, low-cur-rent applications, such as small servo motor control, power MOSFET gate drivers, and other switching applications.



92 **S**

SOT-23 (TO-236AB) 2N7002/NDS7002A



Ordering Information

Part Number	Marking	Package	Packing Method	Min Order Qty / Immediate Pack Qty
2N7000	2N7000	TO-92 3L	Bulk	10000 / 1000
2N7000-D74Z	2N7000	TO-92 3L	Ammo	2000 / 2000
2N7000-D75Z	2N7000	TO-92 3L	Tape and Reel	2000 / 2000
2N7000-D26Z	2N7000	TO-92 3L	Tape and Reel	2000 / 2000
2N7002	702	SOT-23 3L	Tape and Reel	3000 / 3000
NDS7002A	712	SOT-23 3L	Tape and Reel	3000 / 3000

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. Values are at $T_c = 25^{\circ}C$ unless otherwise noted.

Symbol	Baramatar		Unit			
Symbol	Falameter	2N7000	2N7002	NDS7002A		
V _{DSS}	Drain-to-Source Voltage		60		V	
V _{DGR}	Drain-Gate Voltage ($R_{GS} \le 1 M\Omega$)		60		V	
V _{GSS}	Gate-Source Voltage - Continuous		±20		V	
	Gate-Source Voltage - Non Repetitive (tp < 50 μ S)		±40			
Ι _D	Maximum Drain Current - Continuous	200	115	280	mA	
	Maximum Drain Current - Pulsed	500	800	1500		
PD	Maximum Power Dissipation Derated above 25°C	400	200	300	mW	
		3.2	1.6	2.4	mW/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range	-55 to	150	-65 to 150	°C	
TL	Maximum Lead Temperature for Soldering Purposes, 1/16-inch from Case for 10 Seconds		300		°C	

Thermal Characteristics

Values are at $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	vmbol Parameter		Unit		
Symbol	Falameter	2N7000	2N7002	NDS7002A	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	312.5	625	417	°C/W

Electrical Characteristics

Values are at $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Conditions	Туре	Min.	Тур.	Max.	Unit		
Off Characteristics									
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I _D = 10 μ A	All	60			V		
I _{DSS}	Zero Gate Voltage Drain	V _{DS} = 48 V, V _{GS} = 0 V	2N7000			1	μA		
Current	Current	V _{DS} = 48 V, V _{GS} = 0 V, T _C = 125°C				1	mA		
		V_{DS} = 60 V, V_{GS} = 0 V	2N7002 NDS7002A			1	μA		
		V_{DS} = 60 V, V_{GS} = 0 V, T _C = 125°C				0.5	mA		
I _{GSSF}	Gate - Body Leakage, Forward	V _{GS} = 15 V, V _{DS} = 0 V	2N7000			10	nA		
		V _{GS} = 20 V, V _{DS} = 0 V	2N7002 NDS7002A			100	nA		
I _{GSSR}	Gate - Body Leakage, Reverse	V _{GS} = -15 V, V _{DS} = 0 V	2N7000			-10	nA		
		V_{GS} = -20 V, V_{DS} = 0 V	2N7002 NDS7002A			-100	nA		

Symbol	Parameter	Conditions	Туре	Min.	Тур.	Max.	Unit
On Char	acteristics						
V _{GS(th)} G	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$	2N7000	0.8	2.1	3	V
		V_{DS} = V_{GS} , I_D = 250 μ A	2N7002 NDS7002A	1	2.1	2.5	
R _{DS(ON)} S	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 500 mA	2N7000		1.2	5	Ω
		V_{GS} = 10 V, I _D = 500 mA, T _C = 125°C			1.9	9	
		V_{GS} = 4.5 V, I _D = 75 mA			1.8	5.3	
		V _{GS} = 10 V, I _D = 500 mA	2N7002		1.2	7.5	
		V _{GS} = 10 V, I _D = 500 mA, T _C = 100°C			1.7	13.5	
		V _{GS} = 5 V, I _D = 50 mA			1.7	7.5	
		V _{GS} = 5 V, I _D = 50 mA, T _C = 100°C			2.4	13.5	
		V _{GS} = 10 V, I _D = 500 mA	NDS7002A		1.2	2	
		V_{GS} = 10 V, I _D = 500 mA, T _C = 125°C	_		2	3.5	
		V _{GS} = 5 V, I _D = 50 mA			1.7	3	
		V _{GS} = 5 V, I _D = 50 mA, T _C = 125°C			2.8	5	
V _{DS(ON)}	Drain-Source On-Voltage	V _{GS} = 10 V, I _D = 500 mA	2N7000		0.6	2.5	V
		$V_{GS} = 4.5 V,$ I _D = 75 mA			0.14	0.4	
		$V_{GS} = 10 V,$ $I_{D} = 500 mA$	2N7002		0.6	3.75	
		$V_{GS} = 5.0 V,$ $I_{D} = 50 mA$	1000000		0.09	1.5	
		$V_{GS} = 10 V,$ $I_D = 500 \text{ mA}$	NDS7002A		0.6	1	-
		$I_{\rm D} = 50 {\rm mA}$			0.09	0.15	
I _{D(ON)}	On-State Drain Current	V _{GS} = 4.5 V, V _{DS} = 10 V	2N7000	75	600		mA
		$V_{GS} = 10 \text{ V},$ $V_{DS} \ge 2 \text{ V}_{DS(on)}$	2N7002	500	2700		
		$V_{GS} = 10 \text{ V},$ $V_{DS} \ge 2 \text{ V}_{DS(on)}$	NDS7002A	500	2700		
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 200 mA	2N7000	100	320		mS
		$\frac{V_{DS} \ge 2V_{DS(ON)}}{I_D = 200 \text{ mA}}$	2N7002	80	320		
		$V_{DS} \ge 2V_{DS(ON)},$ $I_D = 200 \text{ mA}$	NDS7002A	80	320		

Symbol	Parameter	Conditions	Туре	Min.	Тур.	Max.	Unit
Dynamic	Characteristics		•				
C _{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V,	All		20	50	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	All		11	25	
C _{rss}	Reverse Transfer Capacitance		All		4	5	
t _{on}	Turn-On Time	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 25 \Omega, \\ I_{D} = 500 \text{ mA}, \\ V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 25 \Omega$	2N7000			10	ns
			2N7002 NDS7002A			20	.0
t _{off}	Turn-Off Time		2N7000			10	ns
			2N7002 NDS7002A			20	
Drain-So	ource Diode Characteris	tics and Maximum Rati	ngs				
۱ _S	Maximum Continuous Drai	n-Source Diode Forward	2N7002			115	mA
	Current		NDS7002A			280	
I _{SM}	Maximum Pulsed Drain-So	urce Diode Forward	2N7002			0.8	А
	Current		NDS7002A			1.5	
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V,$ $I_{S} = 115 \text{ mA}^{(1)}$	2N7002		0.88	1.5	V
		$V_{GS} = 0 V,$ $I_{S} = 400 \text{ mA}^{(1)}$	NDS7002A		0.88	1.2	

Note:

1. Pulse test : Pulse Width \leq 300 µs, Duty Cycel \leq 2 %.



2N7000 / 2N7002 / NDS7002A — N-Channel Enhancement Mode Field Effect Transistor





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